

Notice of References Cited	Application/Control No. 10/711,504		Applicant(s)/Patent Under Reexamination MCKIMSON, DAVID	
	Examiner George D. Spisich		Art Unit 3616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0220356	10-2006	Baekelandt, Matthew	280/730.2
*	B	US-2004/0227334	11-2004	Chausset, Francois	280/730.2
*	C	US-2004/0178609	09-2004	Totsuka et al.	280/730.2
*	D	US-2004/0075250	04-2004	Choi, Hyeong Ho	280/728.3
*	E	US-6,152,482	11-2000	Patel et al.	280/730.2
*	F	US-6,361,069	03-2002	Saito et al.	280/730.2
*	G	US-6,305,707	10-2001	Ishiyama et al.	280/728.2
*	H	US-6,254,123	07-2001	Urushi et al.	280/730.2
*	I	US-6,672,027	01-2004	Mizutani et al.	52/716.5
*	J	US-6,530,594	03-2003	Nakajima et al.	280/730.2
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1 038 736	09-2000	Europe		
	O	JP2000255370	09-2000	Japan		
	P	JP410138858	05-1998	Japan		
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.